

International **IR** Rectifier

PD -94904A

IRG4BC10SDPbF

INSULATED GATE BIPOLAR TRANSISTOR WITH
ULTRAFAST SOFT RECOVERY DIODE

Standard Speed CoPack
IGBT

Features

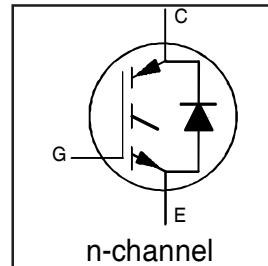
- Extremely low voltage drop 1.1Vtyp. @ 2A
- S-Series: Minimizes power dissipation at up to 3 KHz PWM frequency in inverter drives, up to 4 KHz in brushless DC drives.
- Very Tight Vce(on) distribution
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-220AB package
- Lead-Free

Benefits

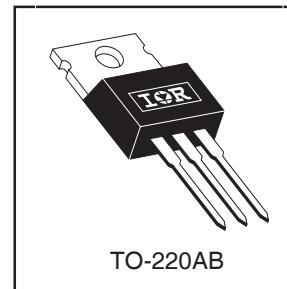
- Generation 4 IGBTs offer highest efficiencies available
- IGBTs optimized for specific application conditions
- HEXFRED diodes optimized for performance with IGBTs. Minimized recovery characteristics require less/no snubbing
- Lower losses than MOSFET's conduction and Diode losses

Absolute Maximum Ratings

	Parameter	Max.	Units
V _{CES}	Collector-to-Emitter Voltage	600	V
I _C @ T _C = 25°C	Continuous Collector Current	14	A
I _C @ T _C = 100°C	Continuous Collector Current	8.0	
I _{CM}	Pulsed Collector Current ①	18	
I _{LM}	Clamped Inductive Load Current ②	18	
I _F @ T _C = 100°C	Diode Continuous Forward Current	4.0	
I _{FM}	Diode Maximum Forward Current	18	W
V _{GE}	Gate-to-Emitter Voltage	± 20	
P _D @ T _C = 25°C	Maximum Power Dissipation	38	
P _D @ T _C = 100°C	Maximum Power Dissipation	15	
T _J	Operating Junction and	-55 to +150	°C
T _{STG}	Storage Temperature Range		
	Soldering Temperature, for 10 sec.	300 (0.063 in. (1.6mm) from case)	g (oz)
	Mounting Torque, 6-32 or M3 Screw.	10 lbf·in (1.1 N·m)	



V_{CES} = 600V
V_{CE(on)} typ. = 1.10V
@V_{GE} = 15V, I_C = 2.0A



Thermal Resistance

	Parameter	Min.	Typ.	Max.	Units
R _{0JC}	Junction-to-Case - IGBT	—	—	3.3	°C/W
R _{0JC}	Junction-to-Case - Diode	—	—	7.0	
R _{0CS}	Case-to-Sink, flat, greased surface	—	0.50	—	
R _{0JA}	Junction-to-Ambient, typical socket mount	—	—	80	
Wt	Weight	—	2.0(0.07)	—	g (oz)

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{CES}}$	Collector-to-Emitter Breakdown Voltage ^③	600	—	—	V	$V_{\text{GE}} = 0\text{V}$, $I_C = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{CES}/\Delta T_J}$	Temperature Coeff. of Breakdown Voltage	—	0.64	—	V°C	$V_{\text{GE}} = 0\text{V}$, $I_C = 1.0\text{mA}$
$V_{\text{CE}(\text{on})}$	Collector-to-Emitter Saturation Voltage	—	1.58	1.8	V	$I_C = 8.0\text{A}$ $V_{\text{GE}} = 15\text{V}$
		—	2.05	—		$I_C = 14.0\text{A}$ See Fig. 2, 5
		—	1.68	—		$I_C = 8.0\text{A}$, $T_J = 150^\circ\text{C}$
$V_{\text{GE}(\text{th})}$	Gate Threshold Voltage	3.0	—	6.0		$V_{\text{CE}} = V_{\text{GE}}$, $I_C = 250\mu\text{A}$
$\Delta V_{\text{GE}(\text{th})/\Delta T_J}$	Temperature Coeff. of Threshold Voltage	—	-9.5	—	mV°C	$V_{\text{CE}} = V_{\text{GE}}$, $I_C = 250\mu\text{A}$
g_{fe}	Forward Transconductance ^④	3.65	5.48	—	S	$V_{\text{CE}} = 100\text{V}$, $I_C = 8.0\text{A}$
I_{CES}	Zero Gate Voltage Collector Current	—	—	250	μA	$V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$
		—	—	1000		$V_{\text{GE}} = 0\text{V}$, $V_{\text{CE}} = 600\text{V}$, $T_J = 150^\circ\text{C}$
V_{FM}	Diode Forward Voltage Drop	—	1.5	1.8	V	$I_C = 4.0\text{A}$ See Fig. 13
		—	1.4	1.7		$I_C = 4.0\text{A}$, $T_J = 150^\circ\text{C}$
I_{GES}	Gate-to-Emitter Leakage Current	—	—	± 100	nA	$V_{\text{GE}} = \pm 20\text{V}$

Switching Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge (turn-on)	—	15	22	nC	$I_C = 8.0\text{A}$
Q_{ge}	Gate - Emitter Charge (turn-on)	—	2.42	3.6		$V_{\text{CC}} = 400\text{V}$ See Fig. 8
Q_{gc}	Gate - Collector Charge (turn-on)	—	6.53	9.8		$V_{\text{GE}} = 15\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	76	—	ns	$T_J = 25^\circ\text{C}$
t_r	Rise Time	—	32	—		$I_C = 8.0\text{A}$, $V_{\text{CC}} = 480\text{V}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	815	1200		$V_{\text{GE}} = 15\text{V}$, $R_G = 100\Omega$
t_f	Fall Time	—	720	1080		Energy losses include "tail" and diode reverse recovery.
E_{on}	Turn-On Switching Loss	—	0.31	—		See Fig. 9, 10, 18
E_{off}	Turn-Off Switching Loss	—	3.28	—		
E_{ts}	Total Switching Loss	—	3.60	10.9	mJ	
E_{ts}	Total Switching Loss	—	1.46	2.6		$I_C = 5.0\text{A}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	70	—	ns	$T_J = 150^\circ\text{C}$, See Fig. 10, 11, 18
t_r	Rise Time	—	36	—		$I_C = 8.0\text{A}$, $V_{\text{CC}} = 480\text{V}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	890	—		$V_{\text{GE}} = 15\text{V}$, $R_G = 100\Omega$
t_f	Fall Time	—	890	—		Energy losses include "tail" and diode reverse recovery.
E_{ts}	Total Switching Loss	—	3.83	—		See Fig. 9, 10, 18
L_E	Internal Emitter Inductance	—	7.5	—		Measured 5mm from package
C_{ies}	Input Capacitance	—	280	—	pF	$V_{\text{GE}} = 0\text{V}$
C_{oes}	Output Capacitance	—	30	—		$V_{\text{CC}} = 30\text{V}$ See Fig. 7
C_{res}	Reverse Transfer Capacitance	—	4.0	—		$f = 1.0\text{MHz}$
t_{rr}	Diode Reverse Recovery Time	—	28	42	ns	$T_J = 25^\circ\text{C}$ See Fig.
		—	38	57		$T_J = 125^\circ\text{C}$ 14
I_{rr}	Diode Peak Reverse Recovery Current	—	2.9	5.2	A	$T_J = 25^\circ\text{C}$ See Fig.
		—	3.7	6.7		$T_J = 125^\circ\text{C}$ 15
Q_{rr}	Diode Reverse Recovery Charge	—	40	60	nC	$T_J = 25^\circ\text{C}$ See Fig.
		—	70	105		$T_J = 125^\circ\text{C}$ 16
$dI_{(\text{rec})M}/dt$	Diode Peak Rate of Fall of Recovery During t_b	—	280	—	A/ μs	$T_J = 25^\circ\text{C}$ See Fig.
		—	235	—		$T_J = 125^\circ\text{C}$ 17

Details of note ① through ④ are on the last page

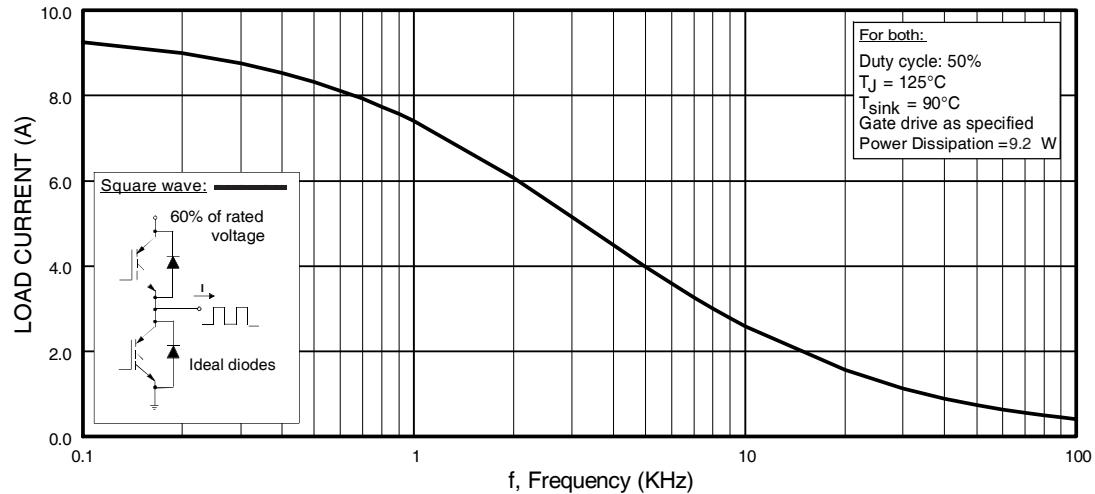


Fig. 1 - Typical Load Current vs. Frequency
 (Load Current = I_{RMS} of fundamental)

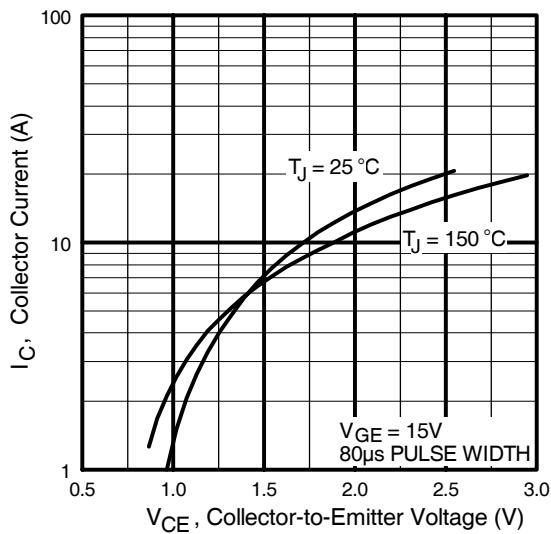


Fig. 2 - Typical Output Characteristics

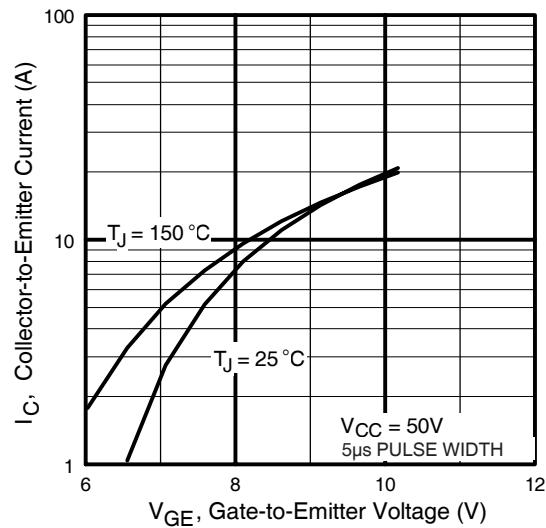


Fig. 3 - Typical Transfer Characteristics

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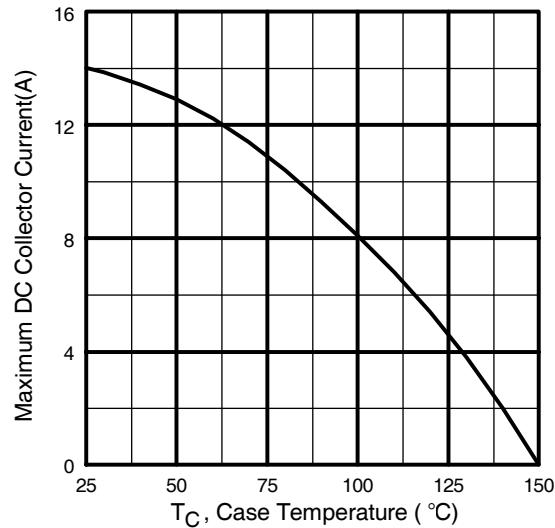


Fig. 4 - Maximum Collector Current vs. Case Temperature

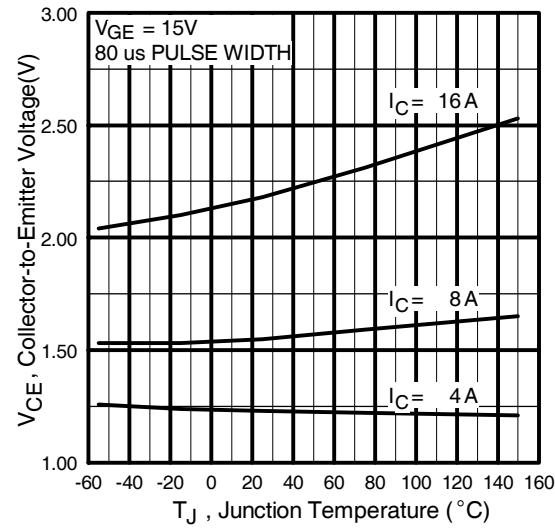


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

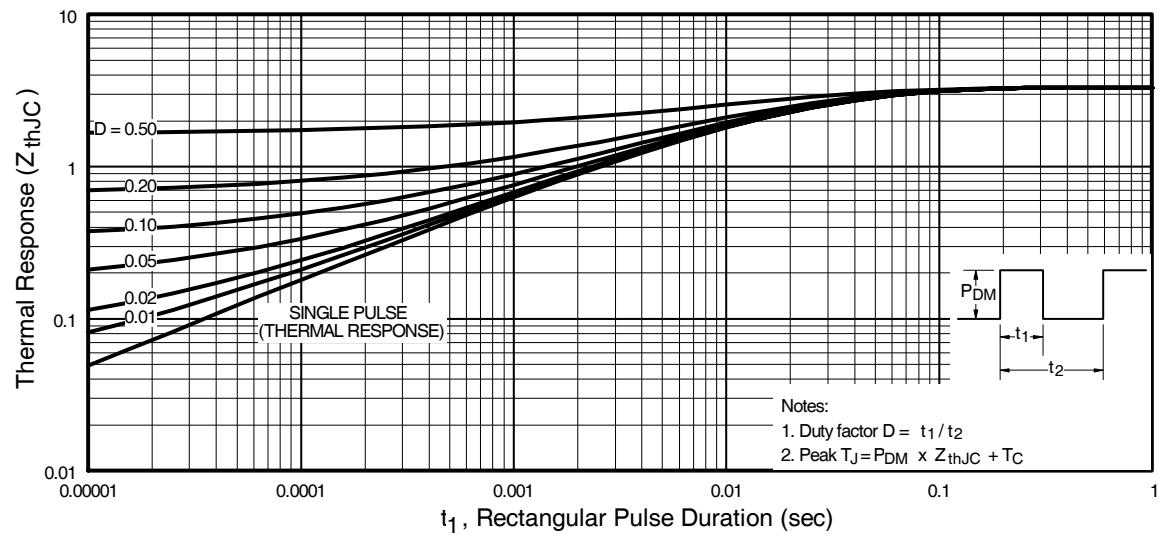


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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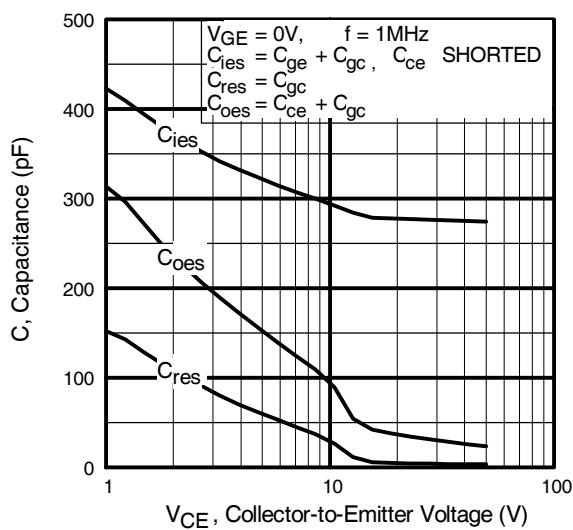


Fig. 7 - Typical Capacitance vs.
Collector-to-Emitter Voltage

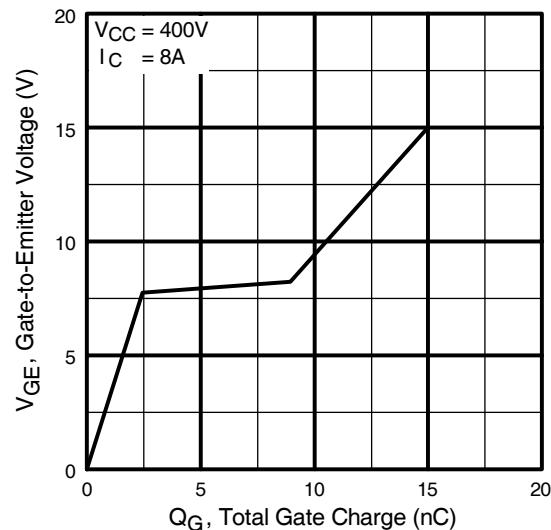


Fig. 8 - Typical Gate Charge vs.
Gate-to-Emitter Voltage

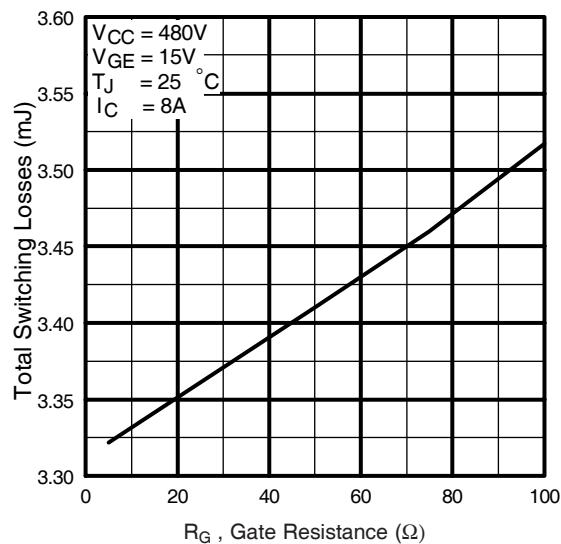


Fig. 9 - Typical Switching Losses vs. Gate
Resistance

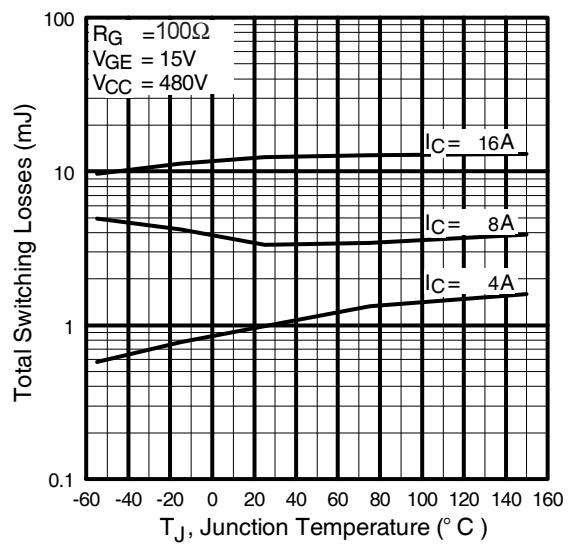


Fig. 10 - Typical Switching Losses vs.
Junction Temperature

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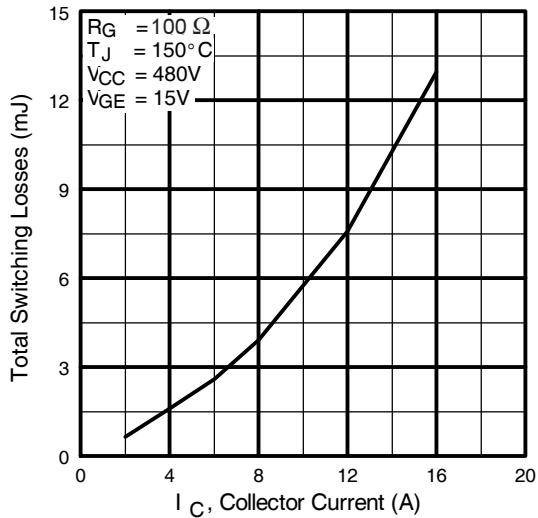


Fig. 11 - Typical Switching Losses vs.
Collector Current

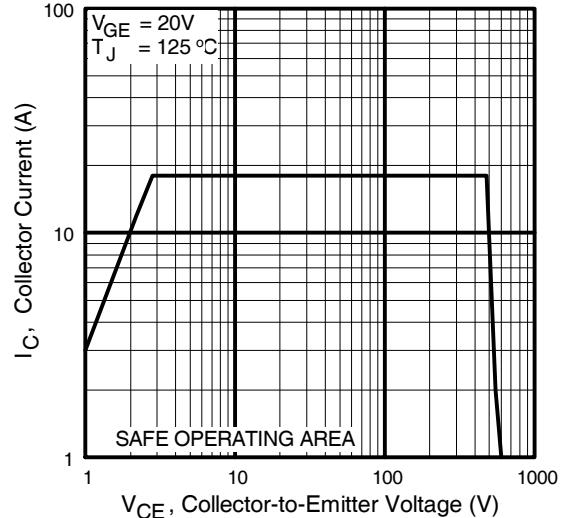


Fig. 12 - Turn-Off SOA

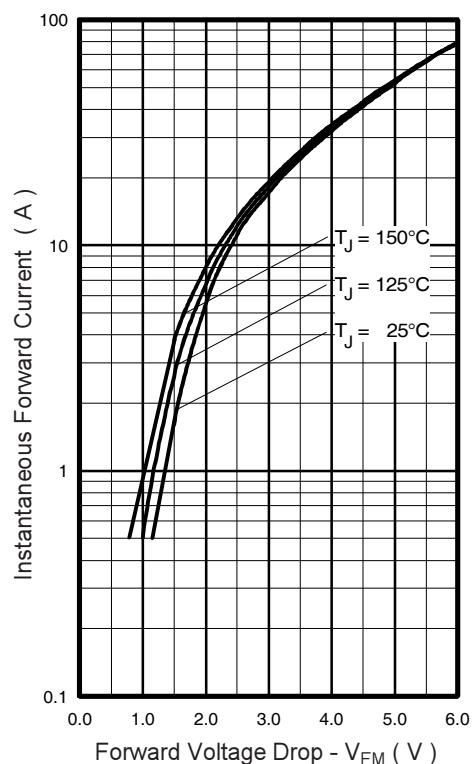


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

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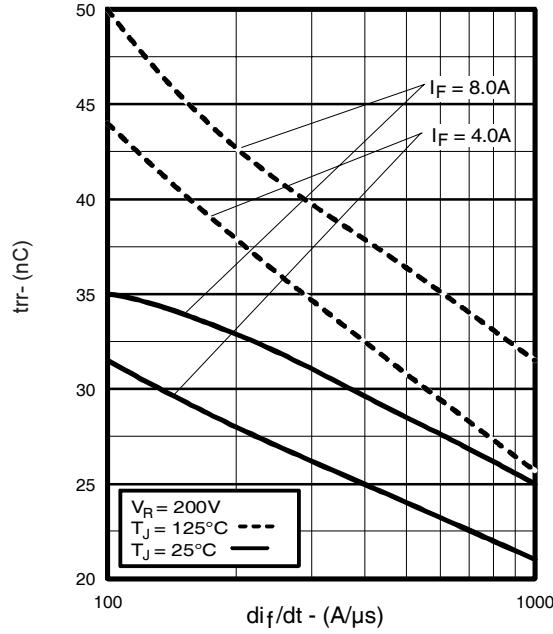


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

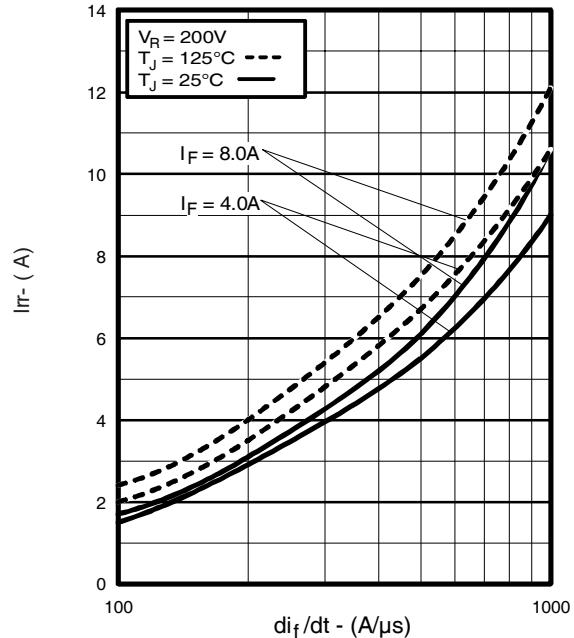


Fig. 15 - Typical Recovery Current vs. di_f/dt

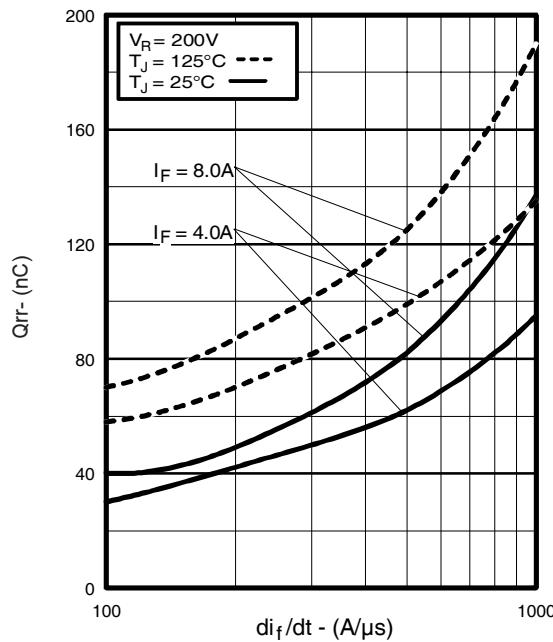


Fig. 16 - Typical Stored Charge vs. di_f/dt

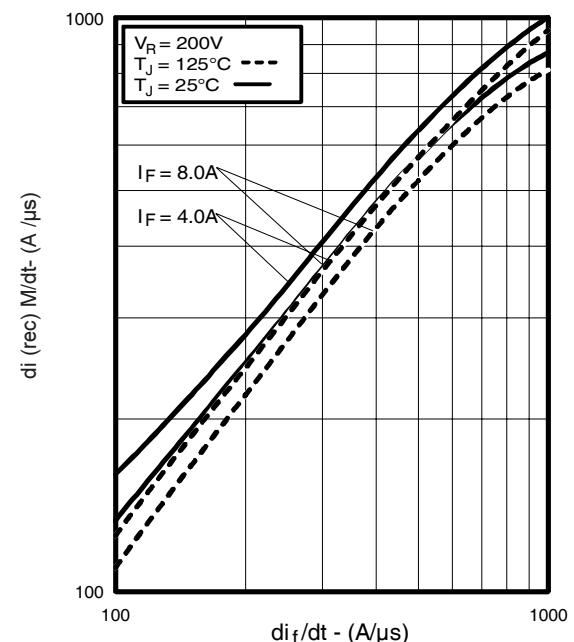


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt ,

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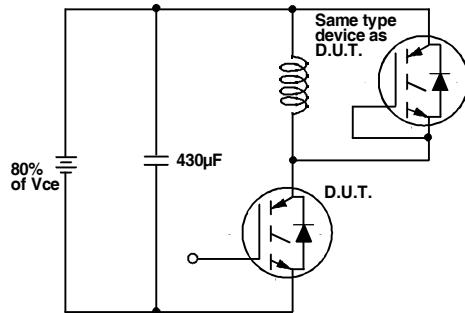


Fig. 18a - Test Circuit for Measurement of
 I_{LM} , E_{on} , $E_{off(diode)}$, t_{rr} , Q_{rr} , I_{rr} , $t_d(on)$, t_r , $t_d(off)$, t_f

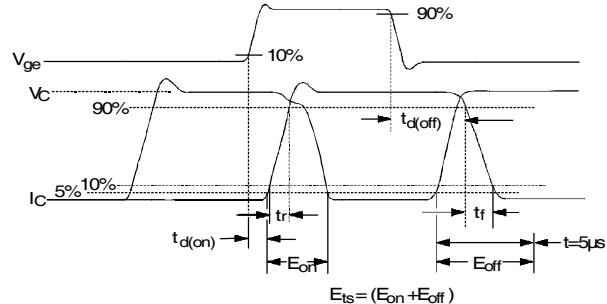


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining
 E_{off} , $t_d(off)$, t_f

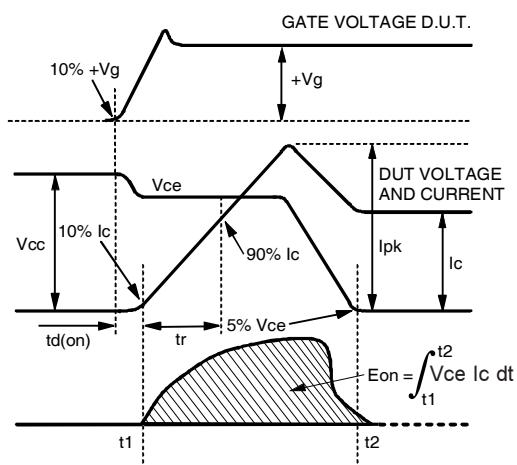


Fig. 18c - Test Waveforms for Circuit of Fig. 18a,
Defining E_{on} , $t_d(on)$, t_r

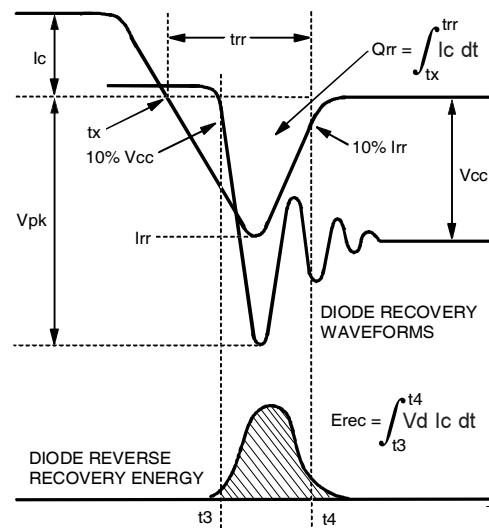


Fig. 18d - Test Waveforms for Circuit of Fig. 18a,
Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

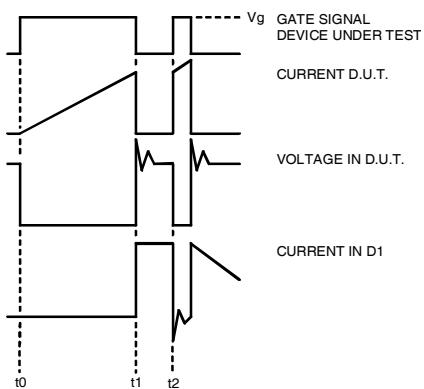


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

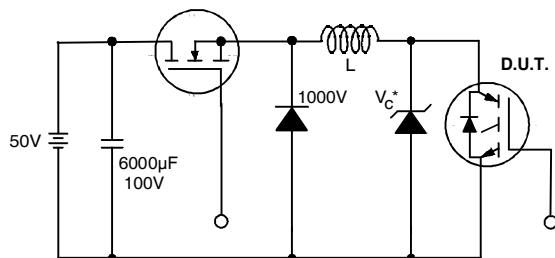


Figure 19. Clamped Inductive Load Test Circuit

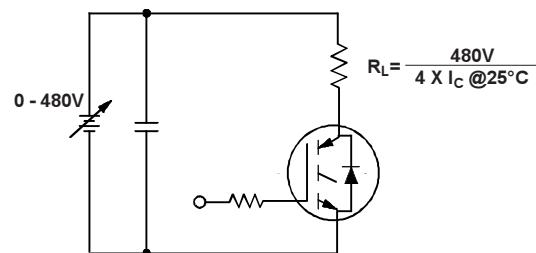


Figure 20. Pulsed Collector Current Test Circuit

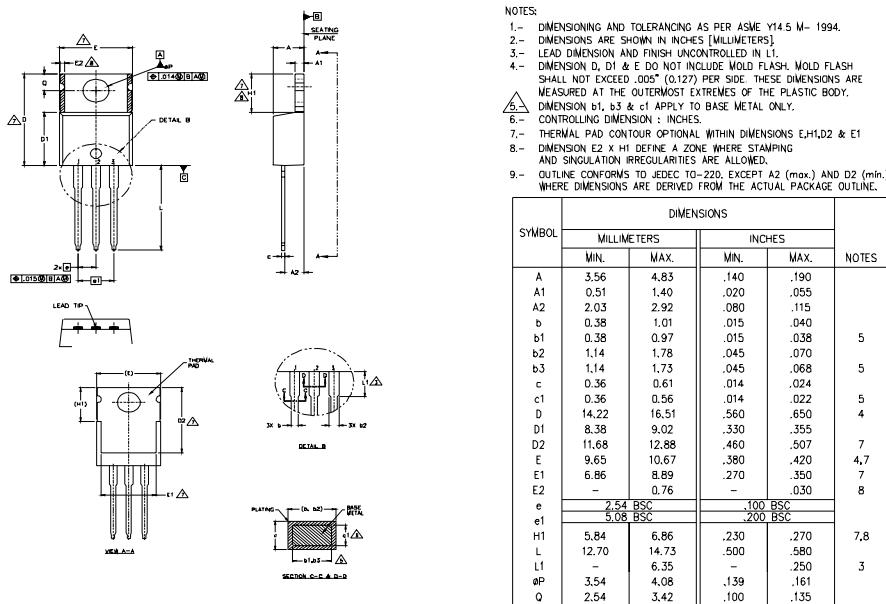
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Notes:

- ① Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- ② $V_{CC}=80\% (V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G = 100W$ (figure 19)
- ③ Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- ④ Pulse width $5.0\mu s$, single shot.

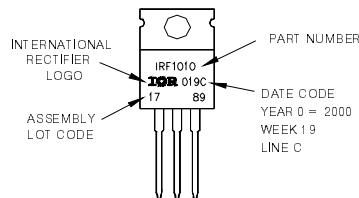
TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
LOT CODE 1789
ASSEMBLED ON WW 19, 2000
IN THE ASSEMBLY LINE 'C'

Note: 'P' in assembly line position
indicates 'Lead - Free'



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.

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IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105
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